



L8822

LEADING TECHNOLOGY  
Semiconductor

20V COMMON-DRAIN DUAL N-CHANNEL TRENCH FET

FEATURES

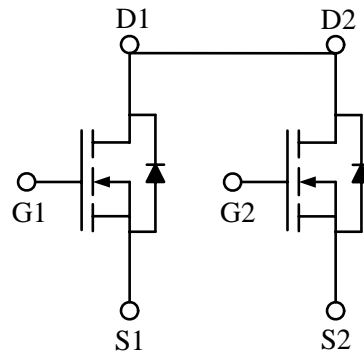
- $BV_{DSS}=20V$
- $V_{gsth}=0.8V$
- $R_{DS(ON)}=14m\Omega @ V_{GS}=10V I_D=7A$
- $R_{DS(ON)}=15.4m\Omega @ V_{GS}=4.5V I_D=7A$
- $Q_g=18.7nC @ V_{GS}=4.5V$

APPLICATION

- Load Switch



TSSOP-8 Top View



ABSOLUTE MAXIMUM RATING

( $T_A = 25^\circ C$  UNLESS OTHERWISE NOTED)

Parameter		Symbol	Rating	Units
Drain-Source Voltage		$V_{DS}$	20	V
Gate-Source Voltage		$V_{GS}$	$\pm 12$	V
Drain Current <sup>A</sup>	$T_A=25^\circ C$	$I_D$	7.9	A
	$T_A=100^\circ C$		5	
	Pulse	$I_{DM}$	30	
Single Pulse Avalanche Current <sup>B</sup>	$T_A=25^\circ C$	$I_{AS}$	11.5	A
Power Dissipation <sup>A</sup>	$T_A=25^\circ C$	$P_D$	1.3	W
	$T_A=100^\circ C$		0.5	
Junction and Storage Temperature Range		$T_J, T_{stg}$	-55 to 150	$^\circ C$
Single Avalanche Energy <sup>B</sup>	L=1mH	$E_{AS}$	180	mJ

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Maximum	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	94	$^\circ C/W$
Maximum Junction-to-Case <sup>A</sup>	$R_{\theta JC}$	41	$^\circ C/W$

Note:

A, The value of  $R_{\theta JA}$  and  $R_{\theta JC}$  were measured with device mounted on tested board based on JESD51-7 requirement, and in still air environment with  $T_A=25^\circ C$  in according to JESD51-2.

B, Single pulse UIS energy, inductor=1mH,  $V_{GS}=10V$ ,  $T_{start}=25^\circ C$ .



## TRENCH FET ELECTRICAL CHARACTERISTICS

SPECIFICATIONS (T <sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)						
Parameter	Symbol	Test Conditions	Limits			Unit
			Min	Typ	Max	
<b>Static</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250μA	20			V
Gate-Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	0.5	0.8	1	
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±12V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 18V, V <sub>GS</sub> = 0V			100	nA
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7A		14	16.5	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7A		15.4	18.5	
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 7A, T <sub>J</sub> = 125°C		20.4	24.5	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 7A		26		S
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1.0MHz		1480		pF
Output Capacitance	C <sub>OSS</sub>			180		
Reverse Transfer Capacitance	C <sub>RSS</sub>			152		
Total Gate Charge (V <sub>GS</sub> = 10V)	Q <sub>g</sub>	V <sub>DS</sub> = 15V, I <sub>D</sub> = 7A		39		nC
Total Gate Charge (V <sub>GS</sub> = 4.5V)				18.7		
Gate-Source Charge	Q <sub>gs</sub>			3		
Gate-Drain Charge	Q <sub>gd</sub>			6.5		
<b>Switching Characteristics<sup>C</sup></b>						
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DS</sub> = 15V, R <sub>GEN</sub> = 3Ω, I <sub>D</sub> = 7A, V <sub>GS</sub> = 10V		5		nS
Rise Time	t <sub>r</sub>			5		
Turn-Off Delay Time	t <sub>d(off)</sub>			35		
Fall-Time	t <sub>f</sub>			8		
Gate Resistance	R <sub>g</sub>	f = 1MHz		1.7		Ω
<b>Body Diode Characteristics</b>						
Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>F</sub> = 1A		0.7	0.9	V
Reverse Recovery Time <sup>C</sup>	t <sub>rr</sub>	V <sub>GS</sub> = 0V, I <sub>F</sub> = 7A, dI <sub>F</sub> /dt = 100A/μs		18		ns
Diode Reverse Charge <sup>C</sup>	Q <sub>rr</sub>				34	

**Notes:**

C, Pulse test: PW ≤ 300μs duty cycle ≤ 2%.



### Typical Electrical Characteristics (N-Channel)

$T_A = +25^\circ\text{C}$ , unless otherwise noted

Figure 1. On-Regions Characteristics

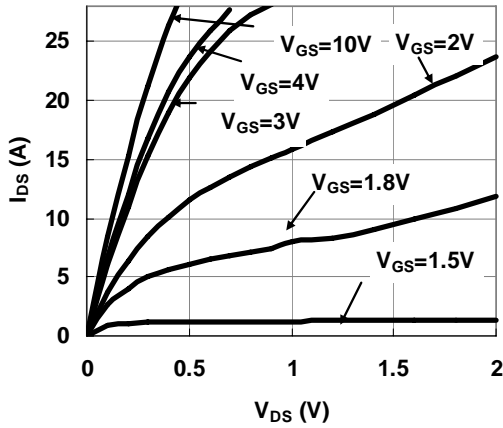


Figure 2. On-Resistance versus Drain Current

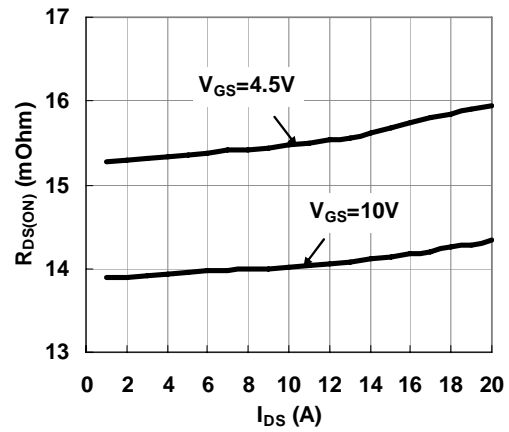


Figure 3. On-Resistance versus Temperature

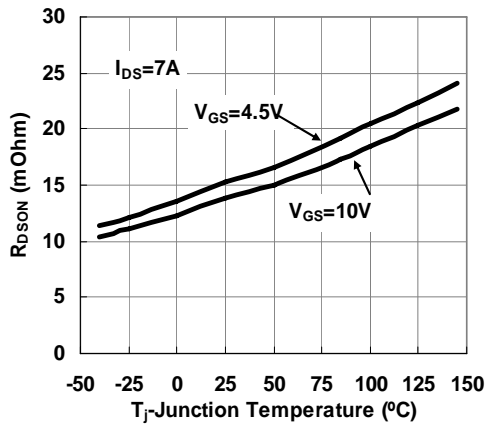


Figure 4. On-Resistance versus Gate to Source Voltage

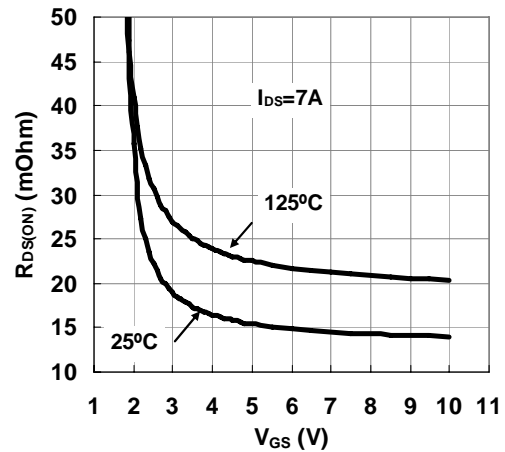


Figure 5. Transfer Characteristics

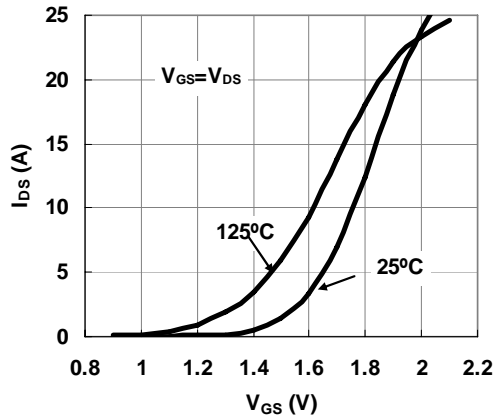
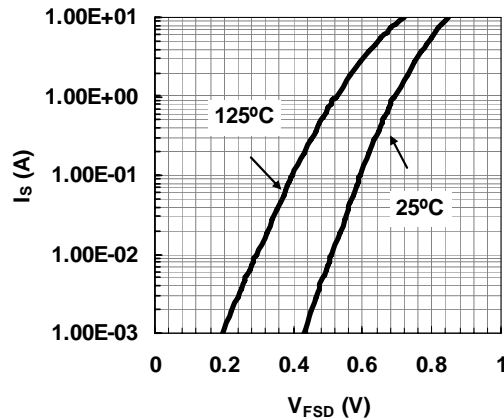


Figure 6. Body Diode Forward Voltage versus Source Current





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Figure 7. Normalized  $V_{TH}$  versus Temperature

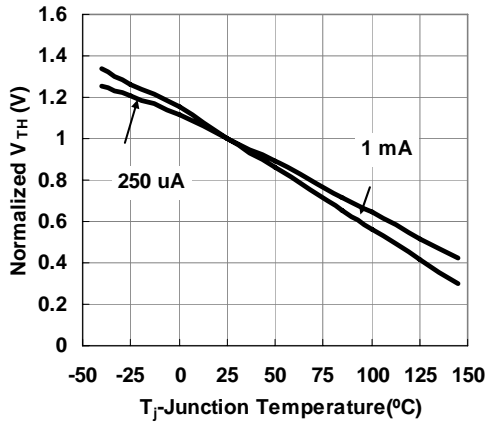


Figure 8. Normalized  $V_{SD}$  versus Temperature

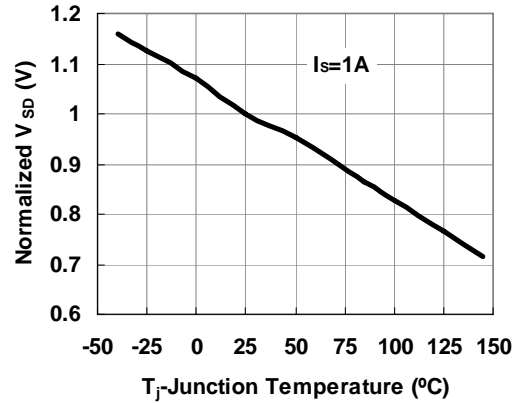


Figure 9. Gate Charge Characteristics

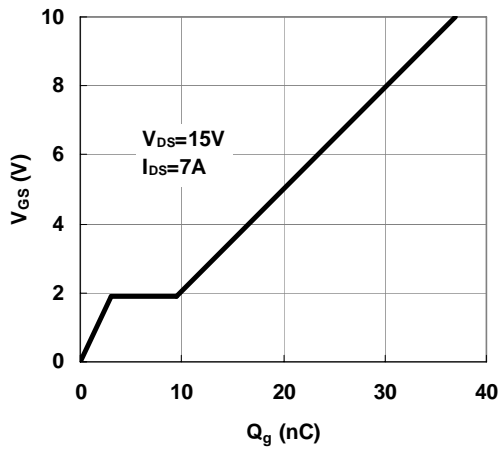
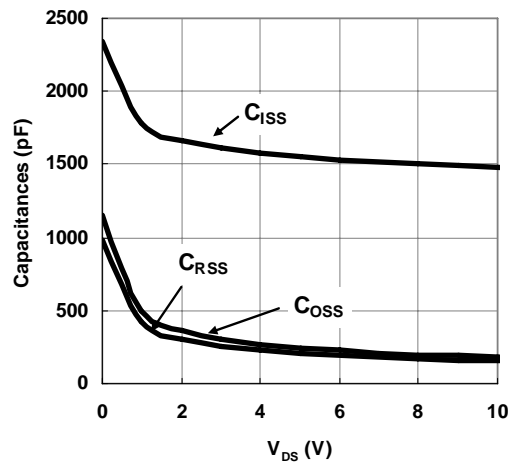


Figure 10. Capacitance Characteristics





### TSSOP-8 Package Outline Drawing

